

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/715,938	WACK ET AL.	
Examiner	Art Unit	
Justin T. Darrow	2132	

•	SEAR	CHED	
Class	Subclass	Date	Examiner
713	160, 161	3/17/2006	JTD
713	. 162, 169	3/17/2006	JTD
380	44, 46	3/17/2006	JTD
380	283, 284	3/17/2006	JTD
726	5, 28	3/17/2006	JTD

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	ļ		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Copending Applications	3/17/2006	JTD		
EAST(Inventors' Names Search)	3/17/2006	JTD		
EAST(US-PGPUB; USPAT)	3/17/2006	JTD		
EAST(EPO; JPO; DERWENT)	3/17/2006	JTD		
,				